Search Notes			

Application/Control N	No. Applicant(s)/Patent und Reexamination	ler
10/727,053	BUI ET AL.	
Examiner	Art Unit	
Gopal C. Ray	2111	

SEARCHED			
Class	Subclass	Date	Examiner
710	104,110,9, 62,3	8/1/2005	GCR
370	254,471	8/1/2005	GCR
370	457,475	8/1/2005	GCR
340	825.52	8/1/2005	GCR
340	3.5	8/1/2005	GCR
379	221.14	8/2/2005	GCR
700	24	8/2/2005	GCR
709	245	8/2/2005	GCR

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (See search history printouts)	8/1/2005	GCR
EAST: USPT (See search history printouts)	8/1/2005	GCR
NPL: IEEE Xplore (See search history printouts)	8/1/2005	GCR
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